

TEST REPORT

Report No.:	8236EU010906W1
Applicant:	SimplyTech Electronics Inc.
Address:	1407 Broadway Suite 1703 New York, NY 10018
Product Name:	Super Fast Charging Slim Power Bank
Model No.:	MAG15-THIN-BLACK
Trademark:	N/A
FCC ID:	2BKTL-MAGT05
Test Standard(s):	47 CFR Part 15 Subpart C
Date of Receipt:	Dec. 09, 2024
Test Date:	Dec. 09, 2024 – Dec. 27, 2024
Date of Issue:	Jan. 20, 2025

ISSUED BY: SHENZHEN EU TESTING LABORATORY LIMITE

Prepared by:

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Revision Record

Report Version	Issued Date	Description	Status
V0	Jan. 20, 2025	Original	Valid



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2 General Information

2.1 Applicant Information

Applicant	SimplyTech Electronics Inc.
Address 1407 Broadway Suite 1703 New York, NY 10018	

2.2 Manufacturer Information

Manufacturer	SimplyTech Electronics Inc.
Address	1407 Broadway Suite 1703 New York, NY 10018

2.3 Factory Information

Factory	SimplyTech Electronics Inc.
Address	1407 Broadway Suite 1703 New York, NY 10018

2.4 General Description of E.U.T.

Product Name	Super Fast Charging Slim Power Bank	
Model No. Under Test	MAG15-THIN-BLACK	
List Model No.	N/A	
Description of Model differentiation	N/A	
	Type-C Input: 5V3A/9V2A/12V1.5A	
Rating(s)	Type-C Output: 5V===3A/9V===2.22A/12V===1.67A	
(utilig(u))	Wireless Charging Output: 5W/7.5W/10W/15W	
	Battery Capacity: 3.85VDC, 5000mAh, 19.25Wh	
Product Type	⊠ Portable	
	Fix Location	
Test Sample No.	-1/2(Normal Sample), -2/2(Engineering Sample)	
Hardware Version	V1.0	
Software Version	V1.0	
1) The above information are declared by the applicant, EU-LAB is not respor		
Remark	for the information accuracy provided by the applicant.	
	2) For a more detailed features description, please refer to the manufacturer's	
	specifications or the User's Manual.	

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2.5 Technical Information of E.U.T.

Wireless Connectivity	/ireless Power Transfer
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The requirement for the following technical information of the EUT was tested in this report:

Technology	WPT
Operating Frequency	110.1-205KHz
Modulation Type	FSK
Antenna Type	Coil Antenna
Antenna Gain(Peak)	0 dBi
Dement	The above information are declared by the applicant, EU-LAB is not responsible
Remark	for the information accuracy provided by the applicant.





3 Test Summary

3.1 Test Standard

The tests were performed according to following standards:

No.	Identity	Document Title
1	47 CFR Part 15, Subpart C	Intentional radiators of radio frequency equipment
2	ANSI C63.10-2020	American National Standard for Testing Unlicensed Wireless Devices

Remark:

Maintenance of compliance is the responsibility of the manufacturer. Any modification of the product maybe which result in lowering the emission/immunity should be checked to ensure compliance has been maintained.

3.2 Test Verdict

No.	Description	FCC Part No.	Verdict	Remark
1	Antenna Requirement	15.203	Pass	
2	Conducted Emission at AC Power Line	15.207	Pass	
3	Emissions Bandwidth	15.215	Pass	
4	Radiated Emissions	15.209 /15.215(b)	Pass	

3.3 Test Laboratory

Test Laboratory	Shenzhen EU Testing Laboratory Limited
Address	101, Building B1, Fuqiao Fourth Area, Qiaotou Community, Fuhai Subdistrict, Baoan District, Shenzhen, Guangdong, China
Designation Number	CN1368
Test Firm Registration Number	952583

4 Test Configuration

4.1 Test Environment

During the measurement, the normal environmental conditions were within the listed ranges:

Relative Humidity	30% to 60%	
Atmospheric Pressure	86 kPa to 106 kPa	
Temperature	NT (Normal Temperature)	+15℃ to +35℃
Working Voltage of the EUT	NV (Normal Voltage)	120 VAC, 60Hz

4.2 Test Equipment

Conducted Emission at AC power line					
Equipment	Manufacturer	Model No	Serial No	Cal Date	Cal Due Date
L.I.S.N. Artificial Mains Network	Rohde & Schwarz	ENV216	EE-004	2024/01/09	2025/01/08
EMI Test Receiver	Rohde & Schwarz	ESCI	EE-005	2024/01/09	2025/01/08
Test Software	Farad	EZ-EMC	EE-014	N.C.R	N.C.R

Radiated Emission and RF Test					
Equipment	Manufacturer	Model No	Serial No	Cal Date	Cal Due Date
EMI Test Receiver	ROHDE & SCHWARZ	ESPI	EE-006	2024/01/09	2025/01/08
Bilog Broadband Antenna	SCHWARZBECK	VULB 9163	EE-007	2023/01/14	2026/01/13
Double Ridged Horn Antenna	A-INFOMW	LB-10180-NF	EE-008	2023/01/12	2026/01/11
Pre-amplifier	Agilent	8447D	EE-009	2024/01/09	2025/01/08
Pre-amplifier	Agilent	8449B	EE-010	2024/01/09	2025/01/08
MXA Signal Analyzer	Agilent	N9020A	EE-011	2024/01/09	2025/01/08
MXG RF Vector Signal Generator	Agilent	N5182A	EE-012	2024/01/09	2025/01/08
Test Software	Farad	EZ-EMC	EE-015	N.C.R	N.C.R
MIMO Power Measurement Module	TSTPASS	TSPS 2023R	EE-016	2024/01/09	2025/01/08
RF Test Software	TSTPASS	TS32893 V2.0	EE-017	N.C.R	N.C.R
Wideband Radio Communication Tester	ROHDE & SCHWARZ	CMW500	EE-402	2024/02/15	2025/02/14
Loop Antenna	TESEQ	HLA6121	EE-403	2024/02/15	2025/02/14
MXG RF Analog Signal Generator	Agilent	N5181A	EE-406	2024/02/15	2025/02/14
Constant Temperature Humidity Chamber	Guangxin	GXP-401	ES-002	2024/07/30	2025/07/29

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4.3 Description of Support Unit

No.	Title	Manufacturer	Model No.	Serial No.
1	Adapter	МІ	A232-050200U-CN2	EMC-PJ-004
2	Wireless Charging Load	YBZ	ID-ZWX	EMC-PJ-050

4.4 Test Mode

To investigate the maximum EMI emission characteristics generates from EUT, the test system was prescanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned bellow was evaluated respectively.

No.	Description	Remark
TM1	Wireless Output (5W) + Empty Load	
TM2	Wireless Output (5W) + Half Load	
TM3	Wireless Output (5W) + Full Load	
TM4	Wireless Output (7.5W) + Empty Load	
TM5	Wireless Output (7.5W) + Half Load	
TM6	Wireless Output (7.5W) + Full Load	
TM7	Wireless Output (10W) + Empty Load	
TM8	Wireless Output (10W) + Half Load	
TM9	Wireless Output (10W) + Full Load	
TM10	Wireless Output (15W) + Empty Load	Record
TM11	Wireless Output (15W) + Half Load	
TM12	Wireless Output (15W) + Full Load	
TM13	Standby	
Note:	e conditions have been tested. It is found that TM10 is the worst mode, and the	data in the report only

1. All the conditions have been tested. It is found that TM10 is the worst mode, and the data in the report only reflects the worst mode.



4.5 Description of Calculation

4.5.1. Field Strength Calculation

The field strength is calculated by adding the Antenna Factor and Cable Factor and subtracting the Amplifier Gain and Duty Cycle Correction Factor (if any) from the measured reading. The basic equation with a sample calculation is as follows:

FS (dBuV/m) = RA (dBuV) + AF (dB/m) + CL (dB) - AG (dB)

Where FS = Field Strength	CL = Cable Attenuation Factor (Cable Loss)
RA = Reading Amplitude	AG = Amplifier Gain
AF = Antenna Factor	

4.5.2. Disturbance Calculation

The AC mains conducted disturbance is calculated by adding the 10dB Pulse Limiter and Cable Factor and Duty Cycle Correction Factor (if any) from the measured reading. The basic equation with a sample calculation is as follows:

CD (dBuV) = RA (dBuV) + PL (dB) + CL (dB)

Where CD = Conducted Disturbance	CL = Cable Attenuation Factor (Cable Loss)
RA = Reading Amplitude	PL = 10 dB Pulse Limiter Factor

4.6 Measurement Uncertainty

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2.

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Test Item	Measurement Uncertainty		
Conducted Emission	2.64 dB		
Occupied Channel Bandwidth	2.8 %		
RF output power, conducted	0.68 dB		
Power Spectral Density, conducted	1.37 dB		
Unwanted Emissions, conducted	1.84 dB		
Radiated Emission (9kHz- 30MHz)	Ur = 2.50 dB		
Radiated Emission	Ur = 2.70 dB (Horizontal)		
(30MHz- 1GHz)	Ur = 2.70 dB (Vertical)		
Radiated Emission	Ur = 3.50 dB (Horizontal)		
(1GHz- 18GHz)	Ur = 3.50 dB (Vertical)		
Radiated Emission	Ur = 5.15 dB (Horizontal)		
(18GHz- 40GHz)	Ur = 5.24 dB (Vertical)		
Temperature	0.8°C		
Humidity	4%		

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4.7 Deviation from Standards

None.

4.8 Abnormalities from Standard Condition

None.



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5 Test Items

5.1 Antenna requirement

5.1.1 Test Requirement

n	According to FCC §15.203, an intentional radiator shall be designed to ensure that
th	no antenna other than that furnished by the responsible party shall be used with
a	he device. The use of a permanently attached antenna or of an antenna that uses
w	a unique coupling to the intentional radiator shall be considered sufficient to comply
b	with the provisions of this section. The manufacturer may design the unit so that a
ja	proken antenna can be replaced by the user, but the use of a standard antenna
c	ack or electrical connector is prohibited. This requirement does not apply to carrier
S	current devices or to devices operated under the provisions of § 15.211, § 15.213,
ir	§ 15.217, § 15.219, or § 15.221. Further, this requirement does not apply to
Test Requirement	intentional radiators that must be professionally installed, such as perimeter
P	protection systems and some field disturbance sensors, or to other intentional
ra	radiators which, in accordance with § 15.31(d), must be measured at the
ir	installation site. However, the installer shall be responsible for ensuring that the
p	proper antenna is employed so that the limits in this part are not exceeded.

5.1.2 Antenna Anti-Replacement Construction

The Antenna Anti-Replacement as following method:

Protected Method	Description
The antenna is embedded in the product.	The EUT has a permanently and irreplaceable inductive loop antenna.

5.1.3 Antenna Gain

The antenna peak gain of EUT is less than 6 dBi.

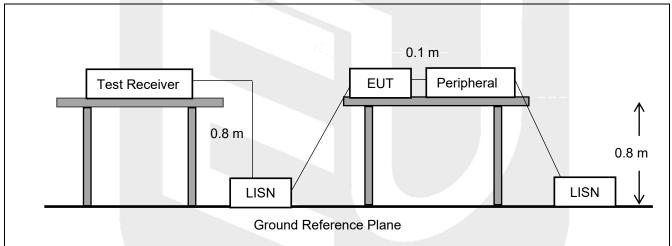


5.2 Conducted Emission at AC Power Line

5.2.1 Test Requirement

Test Requirement:	Except as shown in paragraphs (b)and (c)of this section, for an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies, within the band 150 kHz to 30 MHz, shall not exceed the limits in the following table, as measured using a 50 µH/50 ohms line impedance stabilization network (LISN).		
	Frequency of emission (MHz)	Conducted limit (dBµV)	
		Quasi-peak	Average
<u> </u>	0.15-0.5	66 to 56*	56 to 46*
Test Limit	0.5-5	56	46
	5-30	60	50
*Decreases with the logarithm of the frequency.			
Test Method	Refer to ANSI C63.10-2020 section 6.2, standard test method for ac power-line conducted emissions from unlicensed wireless devices.		

5.2.2 Test Setup Diagram



5.2.3 Test Procedure

The EUT is put on the plane 0.8 m high above the ground by insulating support and connected to the AC mains through Line Impedance Stability Network (L.I.S.N). This provided a 50ohm coupling impedance for the tested equipment. Both sides of AC line are investigated to find out the maximum conducted emission according to the test standard regulations during conducted emission measurement.

The bandwidth of the field strength meter (R&S Test Receiver ESCI) is set at 9kHz in 150kHz~30MHz. The maximum conducted interference is searched using Peak (PK), if the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. Refer to recorded points and plots below.

Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. A device rated for 50/60 Hz operation need not be tested at both frequencies provided the radiated and line conducted emissions are the same at both frequencies.

5.2.4 Test Data

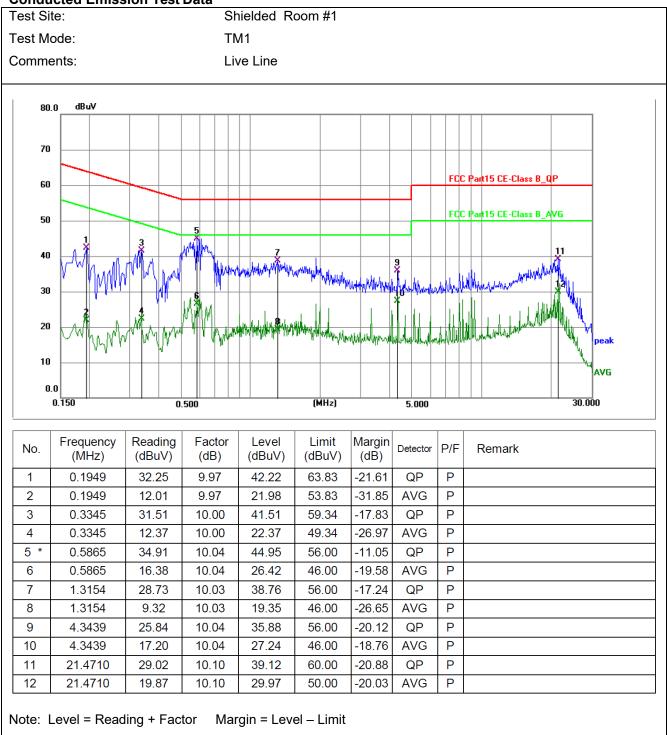
PASS.

Only the worst case data was showed in the report, please to see the following pages.

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Conducted Emission Test Data

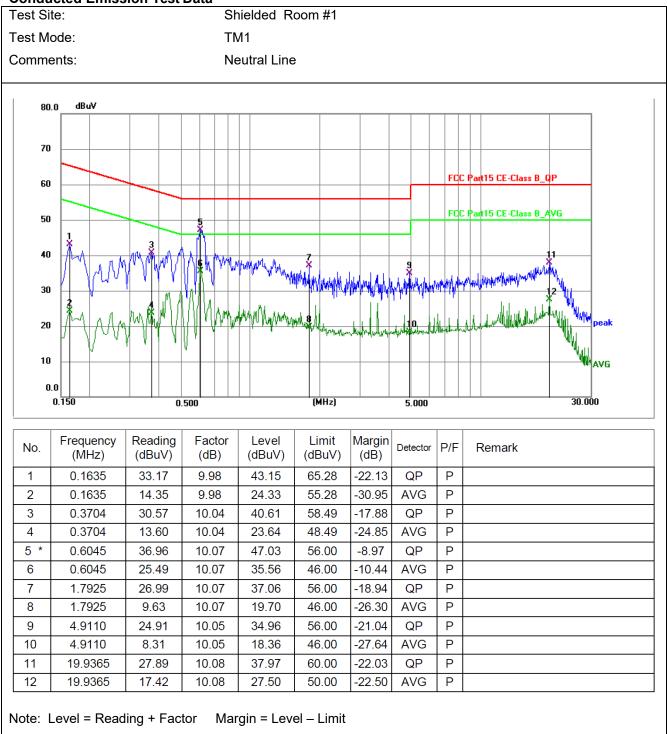


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Conducted Emission Test Data



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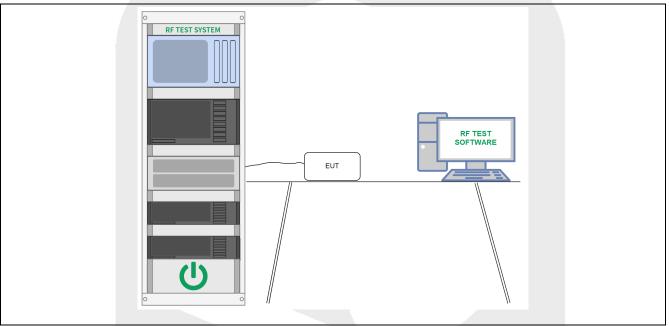


5.3 Emissions Bandwidth

5.3.1 Test Requirement

Test Requirement	Intentional radiators operating under the alternative provisions to the general emission limits, as contained in §§ 15.217 through 15.257 and in subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment the equipment is operated.
Test Method	ANSI C63.10-2020, section 6.9.2 Occupied bandwidth—relative measurement procedure

5.3.2 Test Setup Diagram



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5.3.3 Test Procedure

a) The spectrum analyzer center frequency is set to the nominal EUT channel center frequency. The span range for the EMI receiver or spectrum analyzer shall be between two times and five times the OBW.
b) The nominal IF filter bandwidth (3 dB RBW) shall be in the range of 1% to 5% of the OBW and video bandwidth (VBW) shall be approximately three times RBW, unless otherwise specified by the applicable requirement.

c) Set the reference level of the instrument as required, keeping the signal from exceeding the maximum input mixer level for linear operation. In general, the peak of the spectral envelope shall be more than [10 log (OBW/RBW)] below the reference level. Specific guidance is given in 4.1.5.2.

d) Steps a) through c) might require iteration to adjust within the specified tolerances.

e) The dynamic range of the instrument at the selected RBW shall be more than 10 dB below the target "-xx dB down" requirement; that is, if the requirement calls for measuring the −20 dB OBW, the instrument noise floor at the selected RBW shall be at least 30 dB below the

reference value.

f) Set detection mode to peak and trace mode to maxhold.

g) Determine the reference value: Set the EUT to transmit an unmodulated carrier or modulated signal, as applicable. Allow the trace to stabilize. Set the spectrum analyzer marker to the highest level of the displayed trace (this is the reference value).

h) Determine the "-xx dB down amplitude" using [(reference value) -xx]. Alternatively, this calculation may be made by using the marker-delta function of the instrument.

i) If the reference value is determined by an unmodulated carrier, then turn the EUT modulation ON, and either clear the existing trace or start a new trace on the spectrum analyzer and allow the new trace to stabilize. Otherwise, the trace from step g) shall be used for step j).

j) Place two markers, one at the lowest frequency and the other at the highest frequency of the envelope of the spectral display, such that each marker is at or slightly below the "-xx dB down amplitude" determined in step h). If a marker is below this "-xx dB down amplitude" value, then it shall be as close as possible to this value. The occupied bandwidth is the frequency difference between the two markers. Alternatively, set a marker at the lowest frequency of the envelope of the spectral display, such that the marker is at or slightly below the "-xx dB down amplitude" determined in step h). Reset the marker-delta function and move the marker to the other side of the emission until the delta marker amplitude is at the same level as the reference marker amplitude. The marker-delta frequency reading at this point is the specified emission bandwidth.

k)The occupied bandwidth shall be reported by providing plot(s) of the measuring instrument display; the plot axes and the scale units per division shall be clearly labeled. Tabular data may be reported in addition to the plot(s).

5.3.4 Test Data

PASS.

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Frequency	20dB bandwidth	99% bandwidth	Result
(KHz)	(Hz)	(Hz)	
127	333	283	Pass

gilent Spectrum Analyzer - Occupied BW	Cente		Ra Ra	2:07:37 PMDec 10, 2024 adio Std: None adio Device: BTS	ि Trace/Detector
10 dB/div Ref 10.00 dBm				127.039 kHz -5.2929 dBm	
.og 0.00 10.0					Clear Write
20.0 30.0 40.0 50.0					Average
0.0 0.0 0.0					Max Hold
enter 127 kHz Res BW 100 Hz	#	VBW 300 Hz		Span 1 kHz Sweep FFT	Min Hole
Occupied Bandwidth	283 Hz	Total Power	-3.11 di	Bm	Detecto
Transmit Freq Error	26 Hz	OBW Power	99.00		Average <u>Auto</u> Mar
x dB Bandwidth	333 Hz	x dB	-20.00	dB	

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5.4 Field Strength of Fundamental Emissions and Radiated Emission

5.4.1 Test Requirement

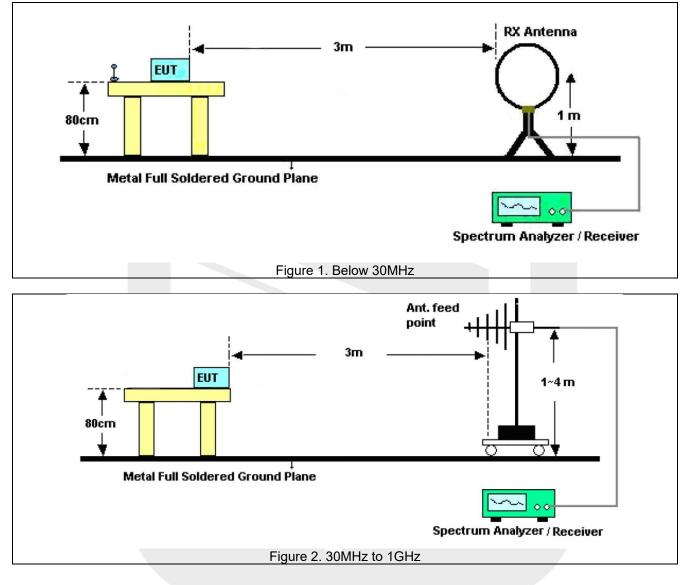
Test Requirement	FCC §15.215; FCC §15.209;					
	FCC §15.215(b):					
		ons outside of the frequency ba	ands shown in these			
		alternative provisions must be attenuated to the emission limits shown in				
	§15.209.In no case shall the level of the unwanted emissions from an intentional					
	÷	hese additional provisions exce				
	fundamental emission.		0			
	FCC §15.209:					
	-	According to FCC section 15.209 (a), except as provided elsewhere in this subpart,				
	the emissions from an intentional radiator shall not exceed the field strength levels					
	specified in the following table:					
	Frequency (MHz)	Field strength	Measurement			
		(microvolts/meter)	distance			
			(meters)			
	0.009-0.490	2400/F(kHz)	300			
	0.490-1.705	24000/F(kHz)	30			
	1.705-30.0	30	30			
	30-88	100 **	3			
	88-216	150 **	3			
	216-960	200 **	3			
Test Limit	Above 960	500	3			
	** Except as provided in paragraph (g), fundamental emissions from intentional					
	radiators operating under this section shall not be located in the frequency bands					
	54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within					
	these frequency bands is permitted under other sections of this part, e.g.,					
	§§ 15.231 and 15.241.					
	NOTE: 4 = Field Other with (dD u) / (du) = 200 for a field Other with (u) / (du)					
	1. Field Strength (dB μ V/m) = 20*log[Field Strength (μ V/m)].					
	2. In the emission tables above, the tighter limit applies at the band edges.					
	3. At frequencies below 30 MHz, measurements may be performed at a distance					
	closer than that specified in the regulations, when performing measurements					
	at a closer distance than specified, the results shall be extrapolated to the					
	specified distance by either making measurements at a minimum of two					
	distances on at least one radial to determine the proper extrapolation factor or					
	by using the square of an inverse linear distance extrapolation factor (40					
	dB/decade). For example, at the frequency 9 kHz, limit @3m = 20*log (2400/f)					
	+ 40log (dlimit/dmeasure) where limit = 300m, dmeasure=3m. limit @3m =					
	20*log (2400/9) + 40log (300/3) = 128.52 (dBµV/m).					
	4. The emission limits shown in the above table are based on measurements					
	employing a CISPR quasi-peak detector except for the frequency bands 9					
	90kHz,110-490 kHz and above 1000 MHZ Radiated emission limits in these					
	90kHz,110-490 kHz		ed emission limits in these			
Test Method		and above 1000 MHZ Radiat ed on measurements em-ployir				

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5.4.2 Test Setup Diagram



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5.4.3 Test Procedure

The measurement frequency range is from 9 kHz to the 10th harmonic of the fundamental frequency. The Turn Table is actuated to turn from 0° to 360°, and both horizontal and vertical polarizations of the Test Antenna are used to find the maximum radiated power.

The power of the EUT transmitting frequency should be ignored.

All Spurious Emission tests were performed in X, Y, Z axis direction. And only the worst axis test condition was recorded in this test report.

Use the following spectrum analyzer settings:

Span = wide enough to fully capture the emission being measured

For 9kHz to 150kHz, Set the spectrum analyzer as:

RBW = 200Hz, VBW =1kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 150kHz to 30MHz, Set the spectrum analyzer as: RBW = 9KHz, VBW =30kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 30MHz to 1000MHz, Set the spectrum analyzer as: RBW = 100kHz, VBW =300kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For above 1GHz,Set the spectrum analyzer as: RBW =1MHz, VBW =1MHz, Detector= Peak, Trace mode= Max hold, Sweep- auto couple. RBW =1MHz, VBW =10Hz, Detector= Average, Trace mode= Max hold, Sweep- auto couple.

For measurement below 1GHz, If the emission level of the EUT measured by the peak detector is 3 dB lower than the applicable limit, the peak emission level will be reported, Otherwise, the emission measurement will be repeated using the quasi-peak detector and reported.

5.4.4 Test Data PASS.

PA55.

Please refer to the following pages.

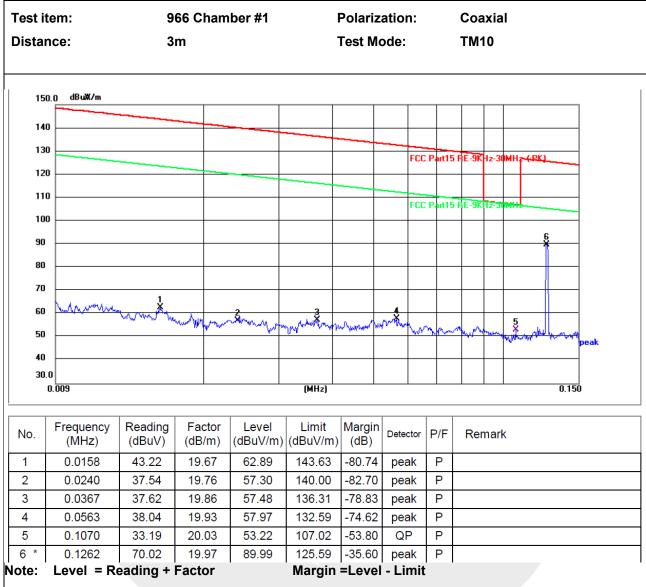
The frequency range from 9KHz to 1000MHz is checked.

Only the worst case data was showed in the report, please to see the following pages.

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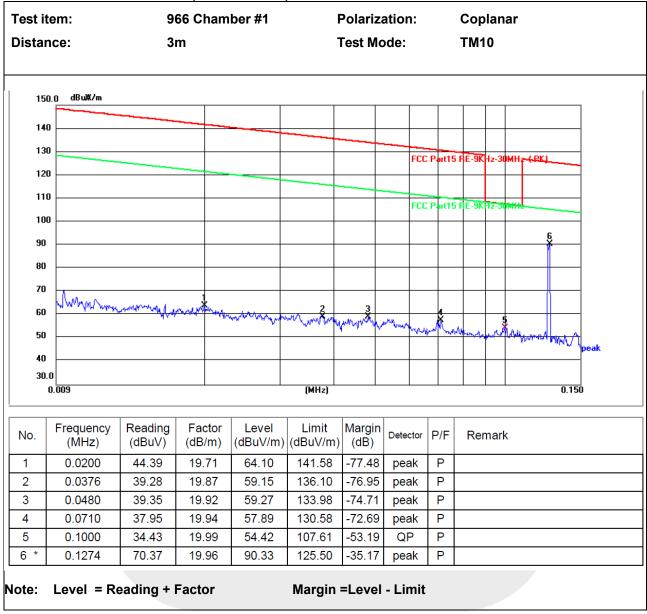
Radiated Emission Test Data (9kHz -150kHz)



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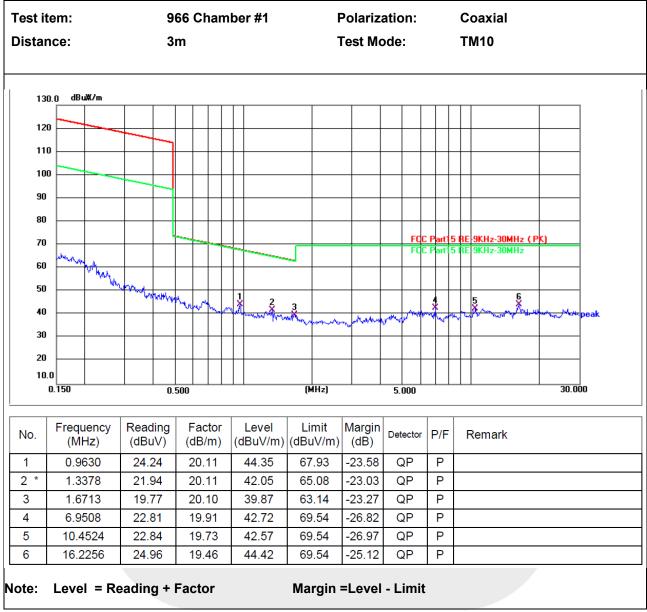
Radiated Emission Test Data (9kHz -150kHz)



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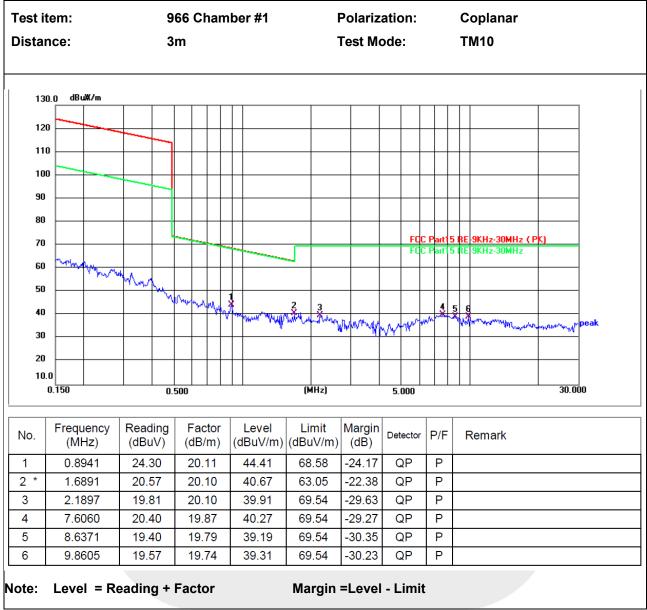
Radiated Emission Test Data (150kHz - 30MHz)



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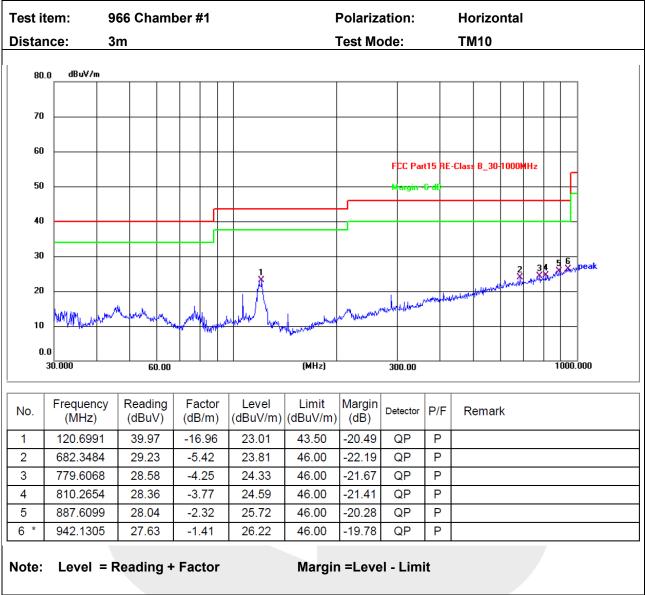
Radiated Emission Test Data (150kHz - 30MHz)



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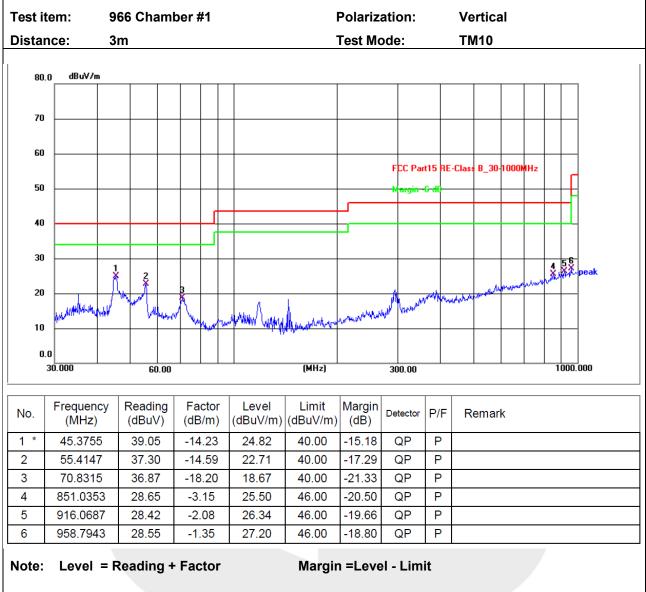
Radiated Emission Test Data (30-1000MHz)



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ANNEX A TEST SETUP PHOTOS

Please refer to the document "8236EU010906W-AA.PDF"

ANNEX B EXTERNAL PHOTOS

Please refer to the document "8236EU010906W-AB.PDF"

ANNEX C INTERNAL PHOTOS

Please refer to the document "8236EU010906W-AC.PDF"



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STATEMENT

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2. The report without China inspection body and laboratory Mandatory Approval (CMA) mark has no effect of proving to the society.

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4. This report is invalid if it is altered, without the signature of the testing and approval personnel, or without the "inspection and testing dedicated stamp" or test report stamp.

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